Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/800,073	BANEY ET AL.
Examiner	Art Unit
Hanh Phan	2613

	SEARCHED					
Class	Subclass	Date	Examiner			
398	202	05/24607	пр			
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455	189.1	08/24/07	пр			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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